

# MCF51EM256 Performance Assessment with Algorithms Used in Metering Applications

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## 1 Introduction

This application note's objective is to demonstrate the implementation of the following algorithms used in metering applications using Freescale MCF51EM256.

- Square root
- Voltage and current RMS values
- Active energy, active power, apparent power, reactive power, and power factor
- Discrete fourier transform (DFT)
- Total harmonic distortion (THD)

The methodology used is to present the formula for the calculation, discuss its implementation, and present execution performance analysis.

The calculation of the performance required to process the algorithms is estimated. The following assumptions are made:

- The power line frequency is 60 Hz.

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## Test Setup

- The sampling rate is 15.360 kHz, therefore there are 256 samples per power line cycle.
- 256 samples are stored in a double buffer, while one buffer is being updated the other is used for the calculations.

The MCF51EM256 was configured to operate with 25 MHz of bus frequency.

## 2 Test Setup

The DEMOEM demo board was used. The test software project, EM256\_Performance.mcp was developed with CodeWarrior V6.2. The compiler optimization was set to Level 4, faster execution speed. The tests were executed with the CodeWarrior debugger using the Terminal Window application from P&E Micro to visualize the results (configure to 19200 bps, parity none, and 8-bits).

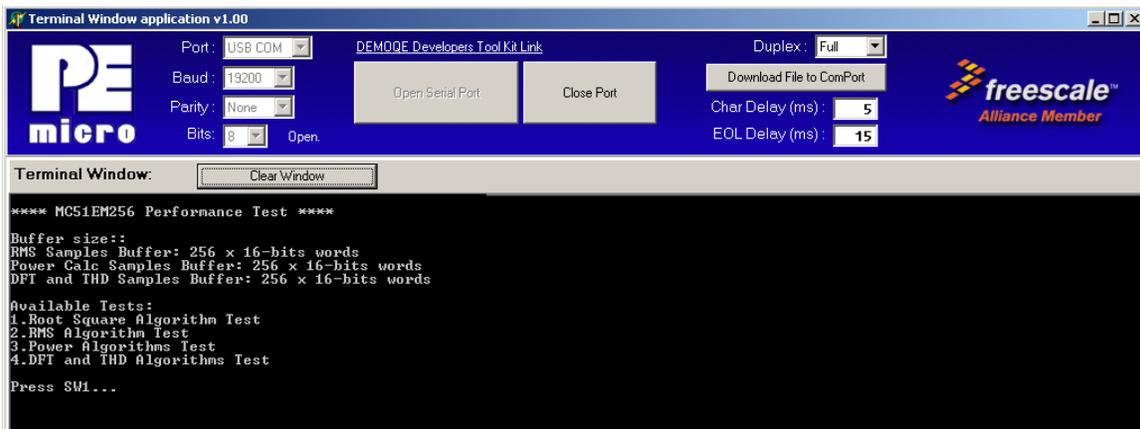


Figure 1. Terminal window application

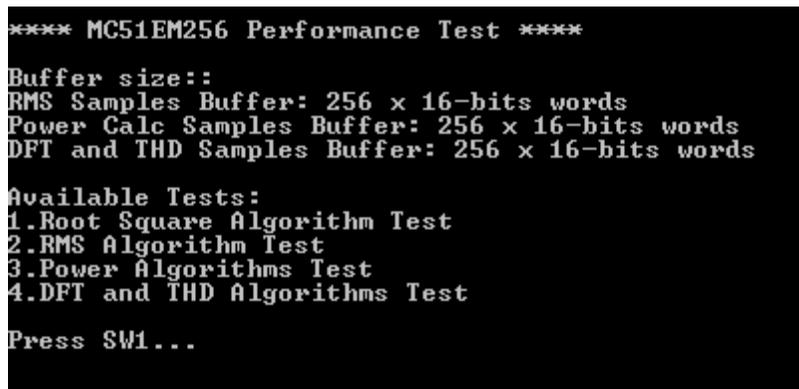


Figure 2. MCF51EM256 performance test initial window

The test project main files are illustrated in [Figure 3](#).

File	Code	Data
Project Settings	1688	460
Startup Code	1688	460
Linker Files	0	0
Includes	0	0
Libs	36096	2459
Sources	16056	18622
main.c	308	18
Common	6056	480
Drivers	9256	18120
Metering	7652	17802
Metering_algorithm_Tests.c	5912	16754
Metering_algorithm_Tests.h	0	0
metering_algorithms.h	0	0
metering_algorithms.c	1740	1048
DFT_coef.h	0	0
inputdata.h	0	0
LCD	892	318
SCI	712	0
TPM	436	4
task_mgr.h	0	0
<b>45 files</b>	<b>53840</b>	<b>21541</b>

**Figure 3. Project structure**

The metering tests are implemented in the files:

- Metering\_algorithm\_Tests.c
- Metering\_algorithm\_Tests.h

The algorithms tests are implemented in the files:

- Metering\_algorithms.c
- Metering\_algorithms.h

The DFT coefficients are in the file:

- DFT\_coef.h

The input data sets used to perform the test are in the file:

- inputdata.h

[Table 1](#) describes the datasets used for the tests.

**Table 1. Input datasets**

Data set name	Vector size	Variable type	Data description
InputVec	256	unsigned 32-bit	0, 1, 2, 3, ... ,254, 255
InputVec1	256	unsigned 32-bit	Random numbers with uniform distribution in the range of 0 to 65535 (16-bits)
InputVec2	256	unsigned 32-bit	Random numbers with uniform distribution in the range of 0 to $2^{32} - 1$
InputVec3	256	unsigned 32-bit	Sequential incremental numbers from $(2^{32} - 256)$ to $(2^{32} - 1)$
InputVecRMS	256	signed 16-bits	60 Hz, 32767 amplitude, 0 phase sine wave
InputVecRMS1	256	signed 16-bits	60 Hz, 1000 amplitude, 0 phase sine wave
InputVecRMS2	256	signed 16-bits	60 Hz, 100 amplitude, 0 phase sine wave
InputVecRMS3	256	signed 16-bits	60 Hz, 10 amplitude, 0 phase sine wave
inputsignal1	256	signed 16-bits	60 Hz, 32767 amplitude, 0 phase sine wave
inputsignal2	256	signed 16-bits	60 Hz, 32767 amplitude, 45° phase sine wave
inputsignal3	256	signed 16-bits	45 Hz, 16000 amplitude, 0 phase sine wave
inputsignal4	256	signed 16-bits	75 Hz, 16000 amplitude, 0 phase sine wave
inputsignal5	256	signed 16-bits	60 Hz, 2000 amplitude, 0 phase sine wave + 180 Hz, 16000 amplitude, 0 phase sine wave

The expected outputs of the algorithms were determined using the excel spreadsheet Performance Analysis.xls. They were obtained doing exactly the same algorithm as implemented in the C code for the MCU.

### 3 Square Root

Formula

The square root is calculated using the Babylonian method, see [Equation 1](#).

$$\begin{aligned}
 x_0 &\approx \sqrt{S} \\
 x_{0+1} &= \frac{1}{2} \left( x_n + \frac{S}{x_n} \right), \\
 \sqrt{S} &= \lim_{n \rightarrow \infty} x_n
 \end{aligned}
 \tag{Eqn. 1}$$

This method calculates the square root by an interaction. The seed value X0 needs to be near the desired square root value to reduce the number of interactions necessary for a good precision result.

The example implementation here uses the following seed value for the square root calculations. Equation 2 is a square root initial guess.

$$X_0 = 2^{\lfloor D/2 \rfloor} \text{ (here D is the number of binary digits)}
 \tag{Eqn. 2}$$

### 3.1 Implementation

```

//-----
// Square root
//
// Input parameter: unsigned 32-bits
// Output parameter: unsigned 16-bits
//-----
/*Square root*/
word SquareRoot(dword A){

    word j; // local variable
    Acc = ASM_FF1(A); // initial seed
    for(j=0; j<MAX_INT; j++){ // execute maximum of MAX_INT interactions
        Acc_temp = (A/Acc + Acc)/2; // Calculate interaction
        if((abs(Acc - Acc_temp) < 0x0001) || (Acc_temp == 0)) // Test is precision is good enough
            break; // break if a good precision was reached
        Acc = Acc_temp; // Save previous interaction
    }
    //Number_of_interactions[i] = (unsigned short) (j+1); // For debugging purposes
    return((word)Acc_temp); // Return parameter
}
    
```

Figure 4. Square root code implementation

```

//-----
// Guess the initial root square seed
//
// Input parameter: unsigned 32-bits
// Output parameter: unsigned 16-bits
//-----
/*Root Square Initial Seed*/
dword ASM_FF1(dword A){
    asm{ //
        ffl.1 d0 // find the first one
    } //
    A = (32-A)>>1; // first one index divided by 2
    A = (unsigned long)1<<A; // multiplies by two
    return(A); // Return parameter
}
    
```

Figure 5. Square root seed generation

### 3.2 Square Root Test Result

The algorithm performance was tested with four different data sets.

**Table 2. Datasets used for a square root test**

Dataset	Dataset name (check table 1)
1 <sup>st</sup>	InputVec
2 <sup>nd</sup>	InputVec1
3 <sup>rd</sup>	InputVec2
4 <sup>th</sup>	InputVec3

The output of the test obtained with the terminal window can be seen in [Figure 6](#)

```

*** 1. Square Root Test***
Press SW1 to Start
Press SW2 to go to '2.RMS Test'

**First Data Set**
# results with error = 11
Sum(E^2)= 11
Total Time = 2768 uS
Average Time = 10.81 uS
Average # of interactions = 0.0
Press SW1 to continue...

**Second Data Set**
# results with error = 0
Sum(E^2)= 0
Total Time = 4549 uS
Average Time = 17.76 uS
Average # of interactions = 0.0
Press SW1 to continue...

**Third Data Set**
# results with error = 0
Sum(E^2)= 0
Total Time = 9530 uS
Average Time = 37.22 uS
Average # of interactions = 0.0
Press SW1 to continue...

**Forth Data Set**
# results with error = 0
Sum(E^2)= 0
Total Time = 5374 uS
Average Time = 20.99 uS
Average # of interactions = 0.0
Press SW1 to continue...

```

**Figure 6. Square root test terminal window output**

[Table 3](#) summarizes the square root test result.

**Table 3. Square root test result (for QE128)**

Square Root Test Result Summary (QE128)					
	Description	Number of results with error	Error standard deviation	Average execution time per square root	Average number of interactions
1st Dataset	values from 0 to 255	4	0.125	11.8 $\mu$ s	3.152
2nd Dataset	Random number in the range of 0 to $2^{16}-1$	0	0	20.1 $\mu$ s	2.738
3rd Dataset	Random number in the range of 0 to $2^{32}-1$	0	0	44.5 $\mu$ s	3.723
4th Dataset	Numbers from $(2^{32}-256)$ to $(2^{32}-1)$ by 1 increments.	0	0	24.3 $\mu$ s	2.000

**Table 4. Square root test result**

Square Root Test Result Summary				
Dataset	Number Results with error	Error standard deviation	Average execution time per square root	Average number interaction
1 <sup>st</sup>	11	0.207	10.97 $\mu$ s	2.27
2 <sup>nd</sup>	0	0	18.3 $\mu$ s	2.73
3 <sup>rd</sup>	0	0	37.47 $\mu$ s	3.72
4 <sup>th</sup>	0	0	21.33 $\mu$ s	2.0

Maximum observed time is 48  $\mu$ s for one 32-bit square root calculation.

## 4 RMS Calculation

The RMS equation is as follows:

$$VRMS = V_{rms} = \frac{1}{N} \times \sum_{i=1}^N V^2(i)$$

Eqn. 3

## 4.1 Implementation

```

//-----
//  RMS
//
//  Input parameter: pointer to 16-bit signed.
//  Output parameter: unsigned 16-bits.
//-----
/* RMS calculation*/
word RMS_calc(short *input){

    Sum = 0; // clear accumulator variable
    for(i=0;i<N_SAMPLES;i+=RMS_DEC){ // execute interaction
#if ASM_SUM == 1 // Assembly implementation of 64-bit sum
        ADD64bits(&Sum,((*input)*(*input))); // call Assembly function
        input+=RMS_DEC; // update pointer
#else // if not using assembly
        Sum = Sum + (input[i])*(input[i]); // multiply and accumulate
#endif //
    } //
    Sum = (Sum>>FAC_SAMPLE_FOR_RMS); // divide final sum by number of samples
    return(SquareRoot((dword)Sum)); // output square root of Sum
}

```

**Figure 7. RMS algorithm code implementation**

The intermediate result was stored with 64-bit precision to avoid intermediate results overflow.

The following implementation optimizations were made to reduce the execution time:

- Implementation of a 32-bit addition with 64-bit accumulation in assembly
- Use of pointers instead of arrays
- Division implemented by shifting

Figure 8 shows the 64-bit addition implemented in assembly.

```

//-----
//  64-bit accumulate
//
//  Input parameter: signed 64-bits pointer
//  Output parameter: signed 32-bits
//-----
/*64-bit accumulate*/
asm void ADD64bits(long long* ACC, long A){

    ADD.L D0,4(A0) // Add 32-bit to 64-bit accumulator
    BCC OUT // Check overflow
    ADDQ.L #01,(A0) // if overflow increase MS 32-bits of ACC
OUT: //
    RTS // Return
}

```

**Figure 8. 32-bits addition to 64-bit accumulator**

A “define” controls if the algorithms use the standard C compiler 64-bit addition or the proposed assembly implementation. The “define” is in the metering\_algorithms.h and is shown below. If defined as 1 it uses the assembly 64-bit addition. If defined as 0 use the standard C addition.

```
# define ASM_SUM 1
```

The RMS implementation allows the configuration of the number of samples to be used for the calculation. The SAMPLE\_FOR\_RMS define shown below controls and can be found at the top of the metering\_algorithms.h file.

```
# define Sample_FOR_RMS 32
```

## 4.2 RMS Test Results

The algorithm performance was tested with four different data sets.

**Table 5. Datasets used for the RMS test**

Dataset	Data set name (check table 1)
1 <sup>st</sup>	InputVecRMS
2 <sup>nd</sup>	InputVecRMS1
3 <sup>rd</sup>	InputVecRMS2
4 <sup>th</sup>	InputVecRMS3

Figure 9 illustrates the RMS test terminal window output.

```

*** 2.RMS Test***
Press SW1 to Start
Press SW2 to go to '3.Power Calculation Test'

**First Data Set**
Total Time = 277 uS
RMS result = 23169

**Second Data Set**
Total Time = 267 uS
RMS result = 707

**Third Data Set**
Total Time = 257 uS
RMS result = 70

**Fourth Data Set**
Total Time = 248 uS
RMS result = 7

Press SW1 to continue...
    
```

**Figure 9. RMS Test terminal output (# samples = 256)**

The RMS tests were repeated using 256, 128, 64, and 32 samples to evaluate the execution time versus precision trade-off. The results are shown in the [Table 5](#) and [Table 6](#).

**Table 6. RMS execution time**

RMS Execution Time				
Dataset	256 Samples	128 Samples	64 Samples	32 Samples
• 1 <sup>st</sup>	277 $\mu$ s	166 $\mu$ s	103 $\mu$ s	72 $\mu$ s
• 2 <sup>nd</sup>	267 $\mu$ s	156 $\mu$ s	94 $\mu$ s	57 $\mu$ s
• 3 <sup>rd</sup>	257 $\mu$ s	145 $\mu$ s	83 $\mu$ s	52 $\mu$ s
• 4 <sup>th</sup>	248 $\mu$ s	136 $\mu$ s	74 $\mu$ s	43 $\mu$ s

**Table 7. RMS test results precision**

RMS Test Precision					
Dataset	Expected value	256 Samples result	128 Samples result	64 Sample results	32 Sample results
1 <sup>st</sup>	23169.77	23169	23169	23169	23169
2 <sup>nd</sup>	707.11	707	707	707	707
3 <sup>rd</sup>	70.71	70	70	70	70
4 <sup>th</sup>	7.07	7	7	7	7

Observed results are as expected considering the truncation due to quantization.

One additional optimization that can be done is to store the intermediate results in 32-bits precision. This requires normalization of the intermediate values resulting in less precision of the RMS value.

## 5 Power Measurements

Power measurements is a routine that receives as input the voltage buffer, current buffer, and calculates the following outputs:

1. Total energy
2. Active power
3. Reactive power
4. Apparent power
5. Vrms and Irms
6. Power factor

The buffers must contain 256 samples (N) that must correspond to a complete period of the power main.

The outputs are calculated with the following equations:

$$Energy = \sum_{i=0}^N V[i] \times I[i] \tag{Eqn. 4}$$

$$ActivePower = Energy / N \tag{Eqn. 5}$$

$$ApparentPower = Vrms \times Irms \tag{Eqn. 6}$$

$$ReactivePower = \sqrt{ApparentPower^2 - ActivePower^2} \tag{Eqn. 7}$$

$$Power(Factor) = ActivePower / ApparentPower \tag{Eqn. 8}$$

Vrms and Irms are calculated as described in the [Section 4, “RMS Calculation .”](#)

## 5.1 Implementation

```

Input parameter: -Voltage pointer to 16-bit signed.
                 -Current pointer to 16-bit signed.
                 -Output Vector pointer.
                 -Output Time vector pointer.
Output parameter: unsigned 16-bits.
-----
Power_Calc(short *V, short *I, Power_vec *Out, Power_time *tm){
    I A; //local var used as ACC
    t *tempV = V, *tempI = I; //local pointers
    //
    active Energy Calculation //
    rtTPM(); //Start timer to measure execution time
    i = 0; //clear accumulator variable
    for(i=0; i<N_SAMPLES; i++){ //interaction for the 256 samples
        sum = sum + (*tempV++)*(*tempI++); //multiply and accumulate
    } //
    out->Act_Eng = sum; //output result
    out->Act_Eng = Stop_Read_TPM(); //Stop timer to measure execution time
    //
    active Power Calculation //
    rtTPM(); //Start timer to measure execution time
    out->Act_Pwr = (long)(sum>>FAC_N_SAMPLES); //Active Power Calculation
    out->Act_Pwr = Stop_Read_TPM(); //Stop timer to measure execution time
    //
    Voltage RMS Calculation //
    rtTPM(); //Start timer to measure execution time
    out->Vrms = RMS_calc(V); //Voltage RMS calculation
    out->Vrms = Stop_Read_TPM(); //Stop timer to measure execution time
    //
    Current RMS Calculation //
    rtTPM(); //Start timer to measure execution time
    out->Irms = RMS_calc(I); //Current RMS calculation
    out->Irms = Stop_Read_TPM(); //Stop timer to measure execution time
    //
    aparent Power Calculation //
    rtTPM(); //Start timer to measure execution time
    out->Apr_Pwr = (long)((out->Vrms) * (out->Irms)); //Aparent Power Calculation
    if(out->Apr_Pwr < (out->Act_Pwr)) //Check if Aparent power is smaller then active
        out->Apr_Pwr = out->Act_Pwr; //Correct output
    out->Apr_Pwr = Stop_Read_TPM(); //Stop timer to measure execution time
    //
    Power Factor Calculation //
    rtTPM(); //Start timer to measure execution time
    if(out->Apr_Pwr <= (out->Act_Pwr)) //If aparent power equals active
        out->Pwr_fct = 65535; //Power Factor equals one
    else //
        out->Pwr_fct = (word) (((long long)(out->Act_Pwr))<<16)/(out->Apr_Pwr); //calc P. Fct
    out->Pwr_fct = Stop_Read_TPM(); //Stop timer to measure execution time
    //
    reactive Energy Calculation //
    rtTPM(); //Start timer to measure execution time
    out->React_Pwr = (((out->Apr_Pwr)>>16)*((out->Apr_Pwr)>>16)) - (((out->Act_Pwr)>>16)*((out->Act_Pwr)>>16));
    out->React_Pwr = (SquareRoot((dword)A))<<16;
    out->React_Pwr = Stop_Read_TPM(); //Stop timer to measure execution time
}

```

Figure 10. Power calculation implementation code

The energy calculation algorithm used 64-bit intermediate results as well as the Vrms and Irms to ensure maximum precision.

Table 8. Algorithms output data types

Output	Data type
Total energy	64-bit signed
Active Power	32-bit signed
RMS	16-bit unsigned
Reactive Power <sup>1</sup>	32-bit signed
Power factor <sup>2</sup>	16-bit unsigned

- <sup>1</sup> Use 16-bit intermediate result. Higher precision results could be achieved with a 32-bit output square root algorithm.
- <sup>2</sup> 65536 correspond to “1” power factors.

The implementation includes the StartTPM() and Stop\_Read\_TPM() functions. These are used for debug purposes only. These lines must be removed in the final implementation.

The output values are stored in the structure defined as shown in Figure 11.

```

/*Metering Datatypes*/
//Power Measures Structure
typedef struct{
    long long Act_Eng;    // Active Energy
    long Act_Pwr;        // Active Power
    long React_Pwr;      // Reactive Power
    long Apr_Pwr;        // Aparent Power
    word Vrms;           // Vrms
    word Irms;           // Irms
    word Pwr_fct;        // Power_factor
}Power_vec;
    
```

Figure 11. Power variable structure

The Power\_time structure was defined to store measured execution times for debugging purposes only. It may be removed from the implementation if it is not required.

## 5.2 Test Results

The algorithm performance was tested with three different data sets each one having two 256 16-bit inputs, one used as the voltage buffer, and the other used as the current buffer.

Table 9. Power calculation test datasets

Dataset	Data Set Name (check table 1)	
	Voltage input	Current Input
1 <sup>st</sup>	InputVecRMS	InputVecRMS
2 <sup>nd</sup>	inputsignal1	Inputsignal2
3 <sup>rd</sup>	Inputsignal3	Inputsignal4

```

*** 3.Power Calculation Test***
Press SW1 to Start
Press SW2 to go to '4.DFT Test'

First Dataset
Active Energy: 137430225637 @609 uS
Active Power: 536836818 @3 uS
React. Power: 0 @3 uS
Apare. Power: 536836818 @1 uS
Vrms: 23169 @72 uS
Irms: 23169 @72 uS
Power Factor: 65535@ 0 uS

Press SW1 to continue...
    
```

Figure 12. Terminal window output for power calculation test (dataset 1)

**Table 10. 1<sup>st</sup> dataset results table**

1 <sup>st</sup> Dataset Power Calculation Results				
	expected	obtained	error	execution time [μs]
Energy	137430225637	137430225637	0.000000%	609
Act_Pwr	536836819	536836818	0.000000%	3
Vrms	23170	23169	0.003191%	276
Irms	23170	23169	0.003191%	277
Apr_Pwr	536836819	536836818	0.000000%	1
React_Pwr	0	0	0.000000%	3
Prw_fct	65536	65535	0.001526%	0
			Total time	1,169

**Table 11. 2nd Dataset results table**

2 <sup>nd</sup> Dataset Power Calculation Results				
	expected	obtained	error	execution time [μs]
Energy	97178042060	97178042060	0.0000000%	596
Act_Pwr	379601727	379601726	0.0000003%	3
Vrms	23170	23169	0.0043159%	263
Irms	23170	23169	0.0043159%	263
Apr_Pwr	536837910	536802561	0.0065847%	0
React_Pwr	379601727	379453440	0.0390638%	34
Prw_fct	46341	46344	0.0064737%	87
			Total time	1,246

**Table 12. 3rd Dataset results table**

3 <sup>rd</sup> Dataset Power Calculation Results				
	expected	obtained	error	execution time [μs]
Energy	127874757	127874757	0.0000000%	591
Act_Pwr	499511	499510	0.0002002%	3
Vrms	11292	11291	0.0088558%	259
Irms	11292	11291	0.0088558%	261

**Table 12. 3rd Dataset results table (continued)**

<b>Apr_Pwr</b>	127500244	127486681	0.0106376%	1
<b>React_Pwr</b>	127499265	127401984	0.0762993%	24
<b>Prw_fct</b>	257	256	0.3891051%	80
			Total time	1,219

## 6 Discrete Fourier Transform (DFT)

A popular method used for energy metering is the discrete fourier transform (DFT) that can estimate the voltage and current phasors. At the same time it eliminates the DC component and harmonics. The phasors are described as follows:

DFT formula:

$$\begin{aligned}
 Z_{rk} &= \frac{2}{N} \sum_{r=0}^{N-1} Z_{k-r} \cos \frac{2\pi r}{N} \\
 Z_{ik} &= \frac{2}{N} \sum_{r=0}^{N-1} Z_{k-r} \sin \frac{2\pi r}{N}
 \end{aligned}
 \tag{Eqn. 9}$$

Where  $Z_{rk}$  is the phasor's real part,  $Z_{ik}$  is the phasor's imaginary part and both are expressed as functions of the k element.  $Z_{k-r}$  is the k sample, N is the number of samples, and r is the angle step defined for the function sine and cosine functions.

Using this approach in [Equation 10](#) voltages are expressed with the DFT formula:

$$\begin{aligned}
 V_{rk} &= \frac{2}{N} \sum_{r=0}^{N-1} V_{k-r} \cos \frac{2\pi r}{N} \\
 V_{ik} &= \frac{2}{N} \sum_{r=0}^{N-1} V_{k-r} \sin \frac{2\pi r}{N}
 \end{aligned}
 \tag{Eqn. 10}$$

The voltage phasor is obtained by:

$$\begin{aligned}
 |\vec{V}| &= \sqrt{V_r^2 + V_i^2} \\
 \theta &= \tan^{-1} \frac{V_r}{V_i}
 \end{aligned}
 \tag{Eqn. 11}$$

The mean and RMS values are obtained by:

$$\begin{aligned}
 V_{mean} &= |\vec{V}| \\
 V_{RMS} &= \frac{|\vec{V}|}{\sqrt{2}}
 \end{aligned}
 \tag{Eqn. 12}$$

The same mathematical operations are used to obtain the current phasor and are not repeated here.

The complex, active, and reactive power can be expressed in terms of the current and voltage phasors as follows.

$$\begin{aligned}
 S &= VI^* = P + jQ \\
 P &= V_r I_r + V_1 I_1 \\
 Q &= V_1 I_r - V_r I_1
 \end{aligned}
 \tag{Eqn. 13}$$

## 6.1 Implementation

The input parameter is a pointer to a 16-bit signed data buffer.

The output parameter is a structure described in Equation 13. It returns the real and imaginary values of the output complex vector. Both the real and imaginary values are stored as a 32-bit signed value (word).

The intermediate result was stored with 64-bit precision to avoid intermediate results overflow. The implementation uses 32-bit intermediate results, if 64-bit values are not needed to reduce the execution time.

```

typedef struct {
    long Real;
    long Img;
} Complex;
    
```

Figure 13. Complex structure

The sample frequency  $f_s$  and the number of points in the data buffer,  $N$ , determine the fundamental frequency component of the DFT output. The fundamental frequency of the DFT can be calculated using Equation 14.

$$F_k = f_s / N \tag{Eqn. 14}$$

In the case considered for this application note,  $f_s = 15.360$  kHz and  $N = 256$ . Therefore, the  $F_k$  frequency is 60 Hz, exactly the power network frequency being considered. Higher frequency harmonics can be calculated using the formula below, DFT formula for “k” harmonic:

$$\begin{aligned}
 Z_{\text{real}k} &= \frac{2}{N} \sum_{n=0}^{N-1} X_n \cos\left(\frac{2\pi nk}{N}\right) \\
 Z_{\text{img}k} &= \frac{2}{N} \sum_{n=0}^{N-1} x_n \sin\left(\frac{2\pi nk}{N}\right)
 \end{aligned}
 \tag{Eqn. 15}$$

Where “k” is the harmonic number. In this case, the harmonic frequency is:

$$F_k = f_s * k / N \tag{Eqn. 16}$$

## Discrete Fourier Transform (DFT)

Then for the network third harmonic,  $k = 3$  and  $F_k = 180$  Hz.

```

//-----
// DFT
// Input parameter: signed 16-bits pointer
// Output parameter: Complex Structure
//-----
Complex DFT(short *input){
    Complex Res; // Complex structure to store result
    short *P1, *P2; // pointers
    P1= input; // input pointer initialization (Real)
    P2 = &Cos_coef_k_1[0]; // coefficients pointer init (Real)
    //-----
    Sum_D = 0; // clear accumulator variable
    for(i=0;i<N_SAMPLES;i+=DEC){ // calculate real component
        Sum_D = Sum_D + (((*P1)*(*P2))>>DFT_SCALING); // square and accumulate the N_SAMPLES_DFT samples
        P1+=DEC; // increment pointers
        P2+=DEC; // increment pointers
    } //-----
    Res.Real = (long)((Sum_D)>>(FAC_SAMPLE_FOR_DFT + COEF_MAX - 1 - DFT_SCALING)); //-----
    P1= input; // input pointer initialization (Imag)
    P2 = &Sin_coef_k_1[0]; // coefficients pointer init (Imag)
    //-----
    Sum_D = 0; // clear accumulator variable
    for(i=0;i<N_SAMPLES;i+=DEC){ // calculate Img component
        Sum_D = Sum_D + (((*P1)*(*P2))>>DFT_SCALING); // square and accumulate the N=256 buffer samples
        P1+=DEC; // increment pointers
        P2+=DEC; // increment pointers
    } //-----
    Res.Img = (long)((Sum_D)>>(FAC_SAMPLE_FOR_DFT + COEF_MAX - 1 - DFT_SCALING)); //-----
    return(Res); // output the result
}

```

**Figure 14. DFT Implementation for first harmonic**

To allow faster execution speed, the implementation allows selection of the number of samples used for the DFT calculation.

```
#define SAMPLE_FOR_DFT 256 // number of samples used for the DFT
```

The less number of samples used, the faster the algorithm. Using 128 samples or less, (apart from less interactions in the loop), has the additional advantage of storing the intermediate results in 32-bit values.

The implementation for calculating other harmonics require a different Sin\_coef\_k vector. This vector has to be calculated with [Equation 11](#).

## 6.2 Test Result

The algorithm performance was tested with five different data sets, each one having 256 16-bit inputs.

**Table 13. DFT test datasets**

Dataset	Data Set Name (check table 1)
1 <sup>st</sup>	Inputsignal1
2 <sup>nd</sup>	Inputsignal2
3 <sup>rd</sup>	Inputsignal3
4 <sup>th</sup>	Inputsignal4
5 <sup>th</sup>	inputsignal5

```
*** 4.DFT Test***
Press SW1 to Start
Press SW2 to go back to Main Menu

DFT input signal 1: <0 + 32765j> @1318 uS
DFT input signal 1: Fundamental RMS <23168>, THD <608> @65 uS

DFT input signal 2: <23169 + 23169j> @1318 uS
DFT input signal 2: Fundamental RMS <23169>, THD <0> @43 uS

DFT input signal 3: <-8669 + 11640j> @1312 uS
DFT input signal 3: Fundamental RMS <10262>, THD <30072> @72 uS

DFT input signal 4: <11254 + 9054j> @1318 uS
DFT input signal 4: Fundamental RMS <10213>, THD <30891> @80 uS

DFT input signal 5: <2586 + 20694j> @1318 uS
DFT input signal 5: Fundamental RMS <14746>, THD <27581> @71 uS

Press SW1 to continue...
```

Figure 15. Terminal window output for the DFT, THD, and fundamental RMS tests

Figure 16. Real component calculation with errors

DFT Test Precision (Real Component)					
Dataset	Expected Value	256 Samples Result	128 Samples Result	64 Samples Result	32 Samples Result
1 <sup>st</sup>	0	0 (0.0000%)	-1 (-%)	-1 (-%)	-1 (-%)
2 <sup>nd</sup>	23169.8	23169 (0.0035%)	23169 (0.0035%)	23168 (0.0078%)	23169 (0.0035%)
3 <sup>rd</sup>	-8668.5	-8669 (0.0058%)	-8607 (0.7095%)	-8484 (2.1284%)	-8243 (4.9086%)
4 <sup>th</sup>	11254.9	11254 (0.0080%)	11191 (0.5678%)	11062 (1.7139%)	10797 (4.0685%)
5 <sup>th</sup>	2586.4	2586 (0.0155%)	2584 (0.0928%)	2578 (0.3248%)	2554 (1.2527%)

Figure 17. Imaginary component calculation with errors

DFT Test Precision (Imaginary Component)					
Dataset	Expected Value	256 Samples Result	128 Samples Result	64 Samples Result	32 Samples Result
1 <sup>st</sup>	32767	32765 (0.0061%)	32766 (0.0031%)	32765 (0.0061%)	32765 (0.0061%)
2 <sup>nd</sup>	23169.8	23169 (0.0035%)	23169 (0.0035%)	23168 (0.0078%)	23169 (0.0035%)
3 <sup>rd</sup>	11640.8	11640 (0.0069%)	11639 (0.0155%)	11636 (0.0412%)	11624 (0.1443%)
4 <sup>th</sup>	9054.4	9054 (0.0044%)	9054 (0.0044%)	9057 (0.0287%)	9070 (0.1723%)
5 <sup>th</sup>	20695.2	20694 (0.0058%)	20694 (0.0058%)	20694 (0.0058%)	20694 (0.0058%)

Table 14. DFT Calculation times

DFT Execution Time (Complex Phasor)				
Dataset	256 Samples	128 Samples	64 Samples	32 Samples
1 <sup>st</sup>	1318 μs	170 μs	85 μs	46 μs

**Table 14. DFT Calculation times (continued)**

<b>2<sup>nd</sup></b>	1319 μs	170 μs	85 μs	46 μs
<b>3<sup>rd</sup></b>	1312 μs	170 μs	85 μs	46 μs
<b>4<sup>th</sup></b>	1318 μs	170 μs	85 μs	46 μs
<b>5<sup>th</sup></b>	1318 μs	170 μs	85 μs	46 μs

## 7 Total Harmonic Distortion (THD)

The THD of a signal is shown with the following equation:

THD formula

$$THD \equiv \frac{\sqrt{V_2^2 + V_3^2 + V_4^2 + \dots + V_n^2}}{V_1} \tag{Eqn. 17}$$

V1 is the amplitude of the fundamental frequency, and V2, ... Vn are the amplitude of the harmonics.

The fundamental RMS voltage was calculated using the following equation:

$$V_{rms\_fundamenta} = \sqrt{\frac{V_{real}^2 + V_{img}^2}{2}} \tag{Eqn. 18}$$

Vreal is the real part of the DFT phasor and Vimg is the imaginary part of the phasor.

### 7.1 Implementation

The input parameters for the THD are two 16-bit unsigned data values. One for the total RMS and another for the fundamental RMS. The output value is a 32-bit unsigned number. The output number is multiplied by 65536 to display the decimal values with a 16-bit resolution.

The THD implemented code is illustrated in [Figure 18](#).

```

//-----
// THD
//-----
word THD_calc(word Total_RMS, word Fund_RMS){
    if(Total_RMS >= Fund_RMS)
        return( (((dword)(SquareRoot((Total_RMS*Total_RMS) - (Fund_RMS*Fund_RMS)))<<16) / (Fund_RMS)));
    else
        return(0);
}

```

**Figure 18. THD implementation**

The input for the fundamental RMS algorithms are the DFT phasors that consist of two 32-bit signed values. Its implementation is shown in [Figure 13](#). The output parameter is a 16-bit unsigned value.

The fundamental RMS implemented code is illustrated in [Figure 19](#).

## Total Harmonic Distortion (THD)

```

//-----
//  RMS DFT
//-----
word RMS_DFT_calc(Complex A){
    return(SquareRoot(((dword)A.Real*A.Real + (dword)A.Img*A.Img)/2));
}

```

Figure 19. Fundamental RMS calculations

## 7.2 Test Result

The THD and fundamental RMS performance were evaluated with the same datasets used for the DFT. Please refer to [Section 6.2, “Test Result”](#) for the dataset reference.

The results are presented in [Table 16](#).

To calculate the THD and fundamental RMS the following inputs are used:

- DFT phasor of the fundamental frequency
- RMS value calculated by equation 3

The THD and fundamental RMS performance are not affected directly by the number of samples used in the input buffer but are affected by the precision of the input parameters.

The precision of these input parameters affect the outputs precision. (THD and fundamental RMS)

The tests were performed using the DFT phasor and RMS value, both were calculated with 256 samples for the maximum precision of the input values. For information regarding the DFT and RMS algorithms precision, please refer to [Section 6, “Discrete Fourier Transform \(DFT\)”](#) and [Section 4, “RMS Calculation .”](#)

Table 15. THD and fundamental RMS test results

THD and DFT RMS (DFT with 256 points)					
	1st dataset	2nd dataset	3rd dataset	4th dataset	5th dataset
<b>Vrms fund expected</b>	23170	23170	10263	10214	14748
<b>Vrms fund obtained</b>	23168	23169	10262	10213	14746
<b>Vrms fund error</b>	0.00763%	0.00331%	0.00789%	0.01042%	0.01052%
<b>THD expected</b>	0	0	30071	30887	27577
<b>THD obtained</b>	608	0	30072	30891	27581
<b>THD error</b>	—	—	-0.00447%	-0.01393%	-0.01489%
<b>execution time [uS]</b>	65	44	72	80	72

## 8 Conclusions

The goal of this application note is to supply information regarding the MCF51EM256 capability for processing algorithms commonly used in metering with a quantitative approach. Several algorithms were implemented and its execution time and precision measured.

As per the double buffer approached for storing the input sampled data, the time of filling one buffer is the time available for processing the other buffer. In this application note a buffer is considered to be filled within 16.667 ms. Each buffer contains a full period of a 60 Hz sine wave. Therefore, the MCF51EM256 would have less then 16.667 ms to do all the algorithm calculations in a set of 256 samples per phase. Some portion of this time should be left for the other application functionalities, as updating the LCD, managing the user interface, manage eventual communications protocols, perform data normalization, and others.

Table 16 illustrates the processing capability of the MCF51EM256 for implementing a 3-phase metering system.

**Table 16. Summary of MCF51EM256 performance**

Algorithm	Execution Time [uS]	# per phase	# of phases	Total	% of total available time
Energy per phase	610	1	3	1950	11.7%
Active power per phase	3	1	3	9	0.1%
Total RMS per signal with 256 samples	280	0	3	0	0.0%
Total RMS per signal with 128 samples	170	0	3	0	0.0%
Total RMS per signal with 64 samples	110	2	3	780	4.7%
Total RMS per signal with 32 samples	80	0	3	0	0.0%
Apparent Power	1	1	3	3	0.0%
Reactive Power	40	1	3	120	0.7%
Power Factor	90	1	3	270	1.6%
DFT per signal (256 samples) per signal	1320	0	3	0	0.0%
DFT per signal (128 samples) per signal	170	0	3	0	0.0%
DFT per signal (64 samples) per signal	85	6	3	1800	10.8%
DFT per signal (32 samples) per signal	46	0	3	0	0.0%
THD (includes fundamental RMS) per signal	80	1	3	240	1.4%
Application free time				11495	69.0%
		Total metering algorithms time		5172	31.0%
		Total time		16667	100.0%

Conclusions

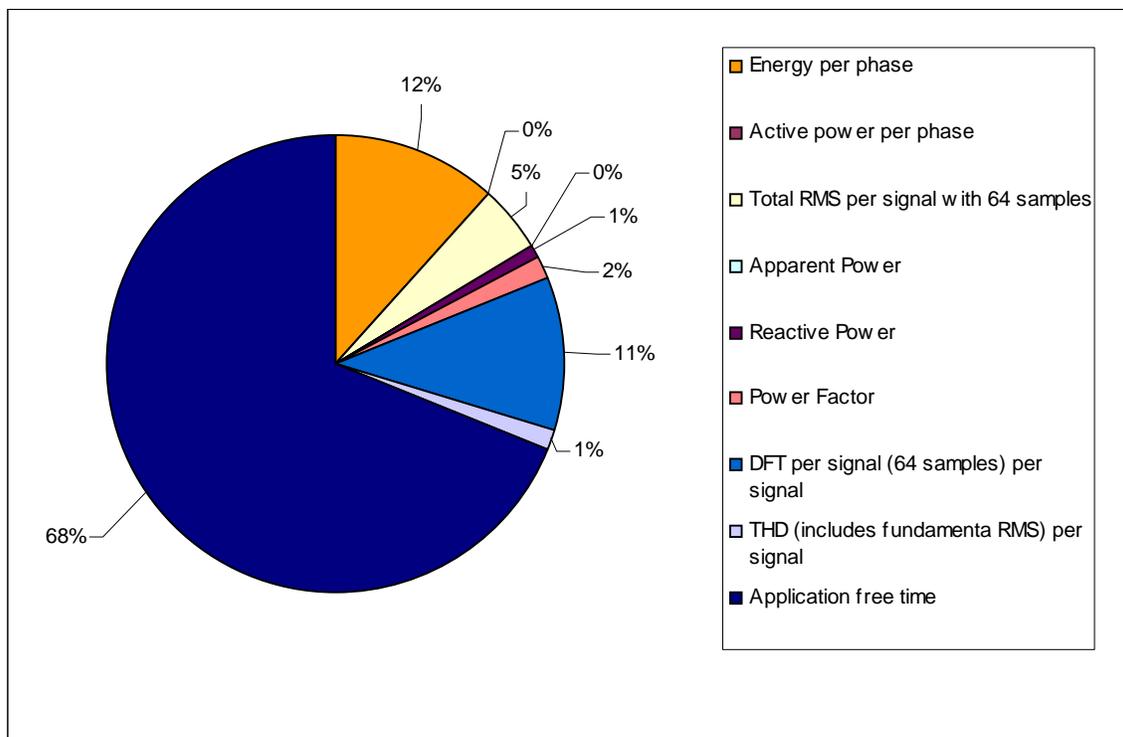


Figure 20. Percentage of CPU performance used for implemented algorithms

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